

## Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	$I_D$
-30V	11mΩ@-10V	-12A
	17mΩ@-4.5V	

## Feature

- TrenchFET Power MOSFET
- Excellent  $R_{DS(on)}$  and Low Gate Charge

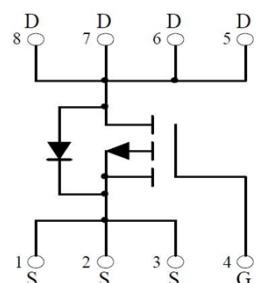
## Application

- Advanced trench process technology
- High density cell design for ultra-low on-resistance
- High power and current handing capability
- Ideal for Lion battery pack applications

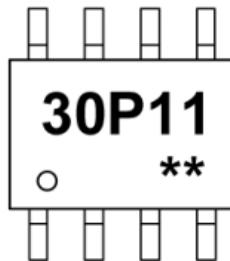
## Package



## Circuit diagram



## Marking



**30P11** =Device Code  
**\*\*** =Week Code

## Absolute maximum ratings

( $T_a=25^\circ\text{C}$  unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DS}$	-30	V
Gate-Source Voltage	$V_{GS}$	$\pm 25$	V
Continuous Drain Current	$I_D$	-12	A
Pulsed Drain Current <sup>1)</sup>	$I_{DM}$	-55	A
Power Dissipation	$P_D$	3.2	W
Thermal Resistance from Junction to Ambient <sup>2)</sup>	$R_{\theta JA}$	39	$^\circ\text{C}/\text{W}$
Junction Temperature	$T_J$	150	$^\circ\text{C}$
Storage Temperature	$T_{STG}$	-55~+150	$^\circ\text{C}$

### Notes:

1. Repetitive rating: Pulse width limited by junction temperature.

2. Surface mounted on FR4 board,  $t \leq 10\text{s}$ .

## Electrical characteristics

( $T_A=25^\circ\text{C}$ , unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
Drain-Source Breakdown Voltage	BV (BR)DSS	$V_{GS} = 0\text{V}, I_D = -250\mu\text{A}$	-30			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -30\text{V}, V_{GS} = 0\text{V}$			-1	$\mu\text{A}$
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$			$\pm 100$	$\mu\text{A}$
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$	-1.2	-1.8	-2.5	V
Drain-Source On-Resistance <sup>1</sup>	$R_{DS(on)}$	$V_{GS} = -20\text{V}, I_D = -12\text{A}$		9.5	12	$\text{m}\Omega$
		$V_{GS} = -10\text{V}, I_D = -12\text{A}$		11	14	
		$V_{GS} = -6\text{V}, I_D = -10\text{A}$		13	18	
		$V_{GS} = -4.5\text{V}, I_D = -10\text{A}$		17	23	
<b>Dynamic Characteristics</b>						
Input Capacitance	$C_{iss}$	$V_{DS} = -15\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$		2070		$\text{pF}$
Output Capacitance	$C_{oss}$			503		
Reverse Transfer Capacitance	$C_{rss}$			302		
<b>Switching Characteristics</b>						
Turn-on Delay Time	$T_{d(on)}$	$V_{GS} = -10\text{V}, V_{DD} = -15\text{V}, R_{GEN} = 3\Omega, R_L = 3\Omega$		12.4		$\text{nS}$
Turn-on Rise Time	$T_r$			8.2		
Turn-off Delay Time	$T_{d(off)}$			25.+		
Turn-off Fall Time	$T_f$			12		
Total Gate Charge	$Q_g$	$V_{DS} = -15\text{V}, I_D = -10\text{A}, V_{GS} = -12\text{V}$		37.4		$\text{nC}$
Gate-Source Charge	$Q_{gs}$			7		
Gate-Drain Charge	$Q_{gd}$			10.4		
<b>Drain-Source Diode Characteristics</b>						
Forward on voltage	$V_{SD}$	$I_{SD} = -1\text{A}, V_{GS} = 0\text{V}$			-1	V

### Note:

1. Repetitive rating: Pulse width limited by junction temperature.
2. Surface mounted on FR4 board,  $t \leq 10\text{s}$ .
3. Pulse Test: Pulse Width  $\leq 80\mu\text{s}$ , Duty Cycle  $\leq 0.5\%$ .
4. Guaranteed by design, not subject to producting.

## Typical Characteristics

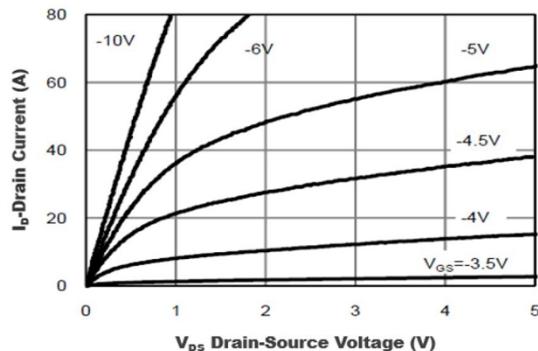


Figure 1. Output Characteristics

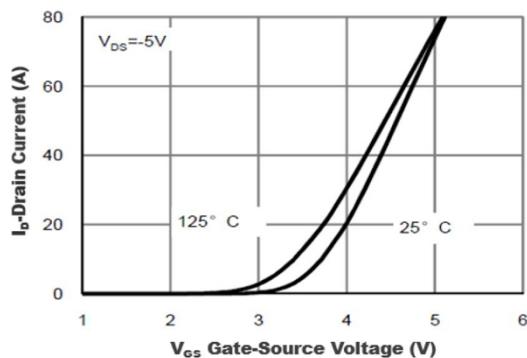


Figure 2. Transfer Characteristics

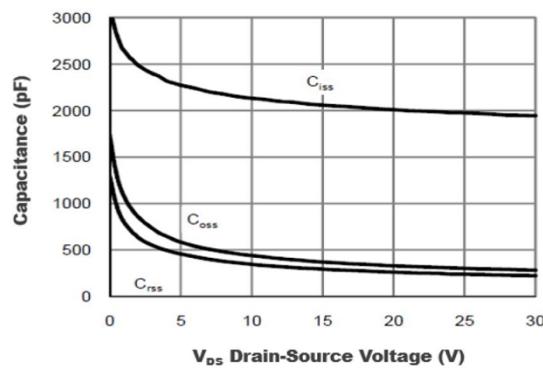


Figure 3. Capacitance Characteristics

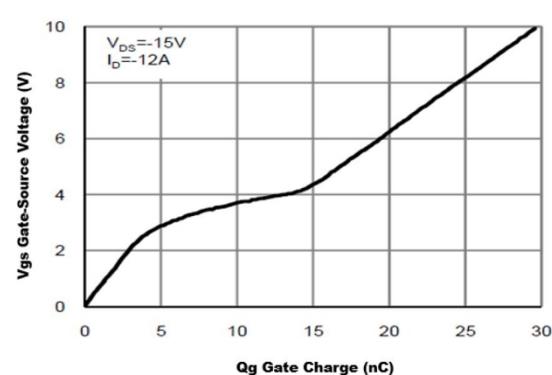


Figure 4. Gate Charge

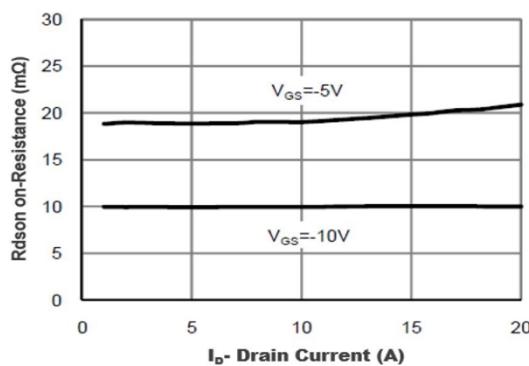


Figure 5. Drain-Source on Resistance

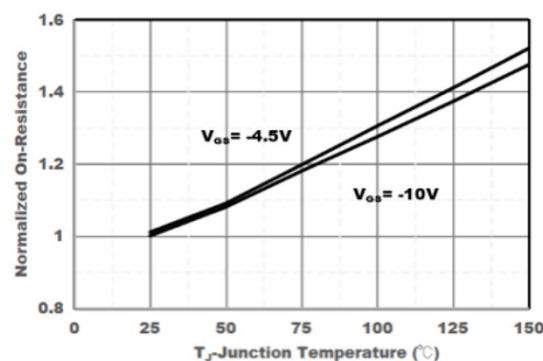


Figure 6. Drain-Source on Resistance

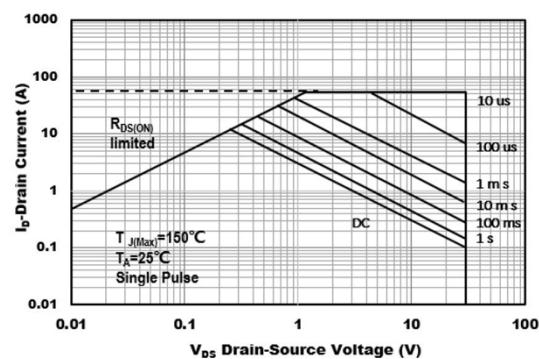


Figure 7. Safe Operation Area

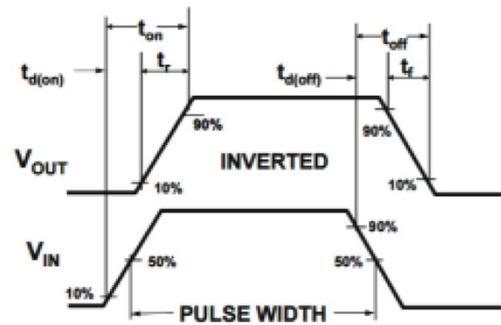
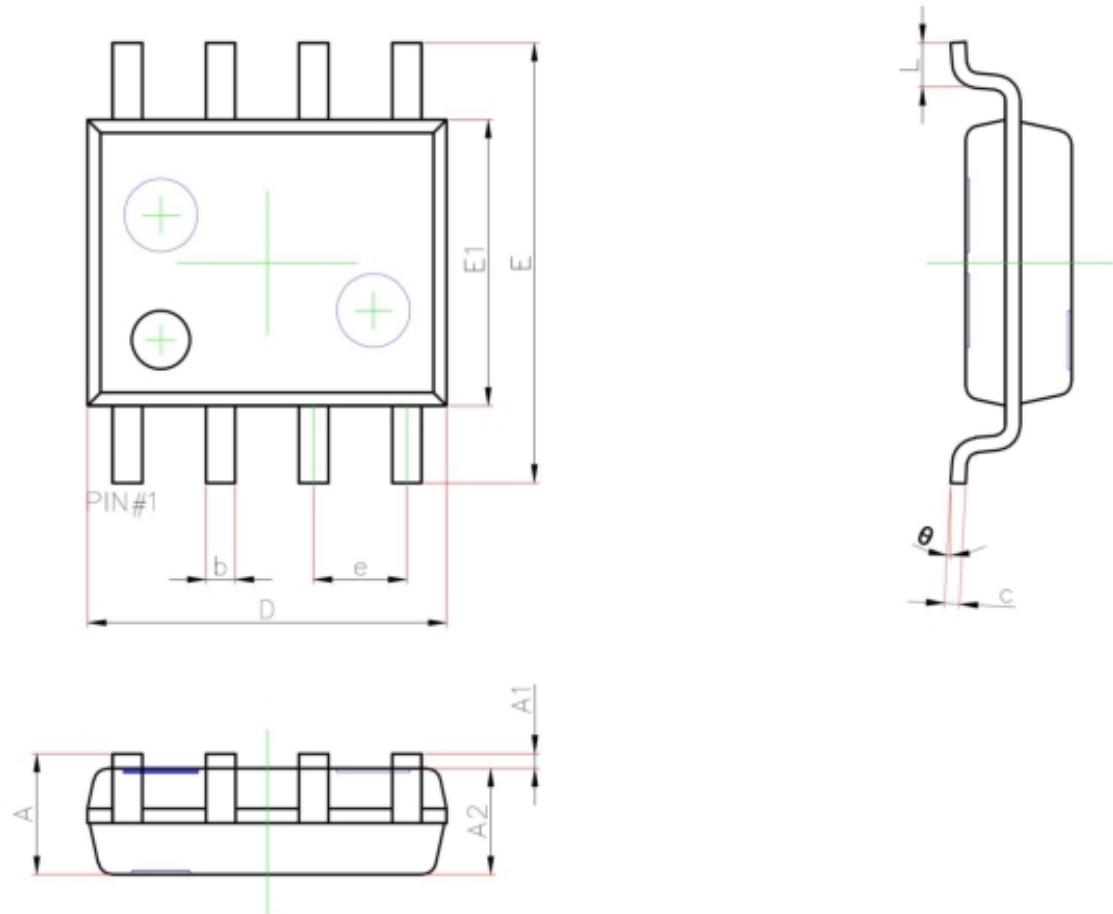


Figure 8. Switching wave

## SOP-8 Package Information



Symbol	Dimensions In Millimeters	
	Min.	Max.
A	1.35	1.75
A1	0.10	0.25
A2	1.35	1.55
b	0.33	0.51
c	0.17	0.25
D	4.80	5.00
e	1.27 REF.	
E	5.80	6.20
E1	3.80	4.00
L	0.40	1.27
θ	0°	8°